

MOS FIELD EFFECT TRANSISTOR 2SK3058

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

This product is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

• Super Low On-State Resistance

RDS(on)1 = 17 m Ω MAX. (VGS = 10 V, ID = 28 A)

 $R_{DS(on)2} = 27 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.0 \text{ V, ID} = 28 \text{ A)}$

- Low Ciss : Ciss = 2100 pF (TYP.)
- Built-in Gate Protection Diode

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK3058	TO-220AB
2SK3058-S	TO-262
2SK3058-ZJ	TO-263

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Drain to Source Voltage (Vgs = 0)	VDSS	60	V
Gate to Source Voltage (Vps = 0)	VGSS(AC)	±20	V
Gate to Source Voltage (VDS = 0)	VGSS(DC)	+20, -10	V
Drain Current (DC)	ID(DC)	±55	Α
Drain Current (Pulse) Note1	D(pulse)	±165	Α
Total Power Dissipation (Tc = 25°C)	PT	58	W
Total Power Dissipation (TA = 25°C)	P⊤	1.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	T _{stg}	-55 to + 150	°C
Single Avalanche Current Note2	las	27.5	Α
Single Avalanche Energy Note2	Eas	75.6	mJ

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1 %

2. Starting Tch = 25 °C, Rg = 25 Ω , Vgs = 20 V \rightarrow 0

THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	2.16	°C/W
Channel to Ambient	Rth(ch-A)	83.3	°C/W

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

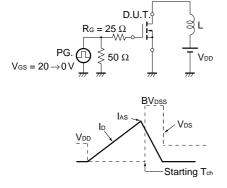


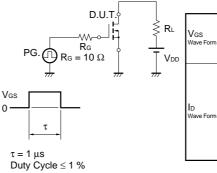
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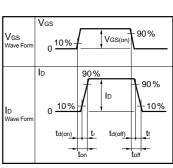
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	R _{DS(on)1}	Vgs = 10 V, ID = 28 A		12	17	mΩ
	RDS(on)2	Vgs = 4.0 V, ID = 28 A		19	27	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.0	1.6	2.0	٧
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 28 A	13	42		S
Drain Leakage Current	Ipss	Vps = 60 V, Vgs = 0 V			10	μΑ
Gate to Source Leakage Current	lgss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Input Capacitance	Ciss	V _{DS} = 10 V		2100		pF
Output Capacitance	Coss	V _G s = 0 V		550		pF
Reverse Transfer Capacitance	Crss	F = 1 MHz		220		pF
Turn-on Delay Time	td(on)	ID = 28 A		36		ns
Rise Time	tr	V _{GS(on)} = 10 V		410		ns
Turn-off Delay Time	td(off)	V _{DD} = 30 V		130		ns
Fall Time	tf	R _G = 10 Ω		260		ns
Total Gate Charge	Q _G	ID = 55 A		45		nC
Gate to Source Charge	Qgs	V _{DD} = 48 V		7		nC
Gate to Drain Charge	Q _{GD}	V _G S = 10 V		13		nC
Body Diode Forward Voltage	VF(S-D)	IF = 55 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 55 A, VGS = 0 V		60		ns
Reverse Recovery Charge	Qrr	di/dt = 100A/μs		100		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

TEST CIRCUIT 2 SWITCHING TIME





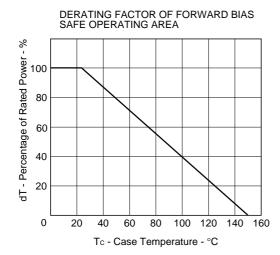


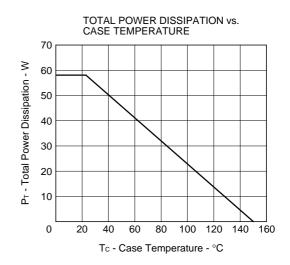
TEST CIRCUIT 3 GATE CHARGE

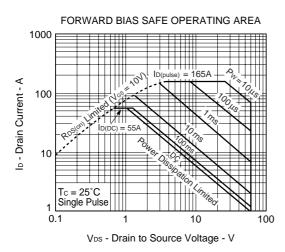
$$\begin{array}{c|c} D.U.T. \\ \hline \\ I_G = 2 \text{ mA} \\ \hline \\ \hline \\ V_{DD} \end{array} \\ \begin{array}{c} R_L \\ \hline \\ V_{DD} \end{array}$$

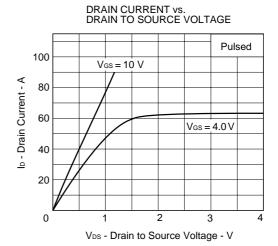


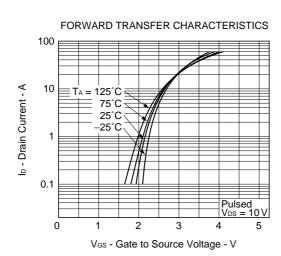
章河CAL CHARACTER®TICS (TA = 25 °C)





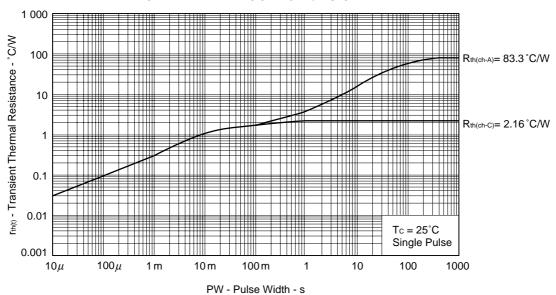


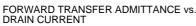


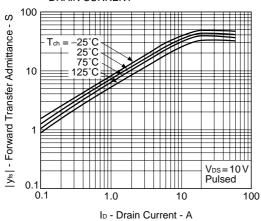


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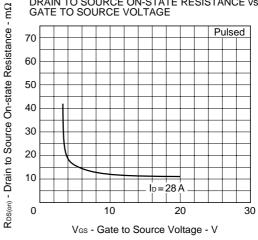
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



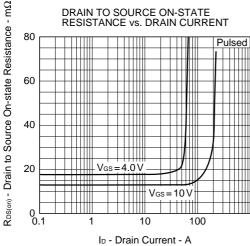




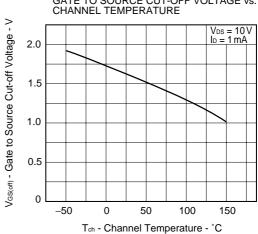
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



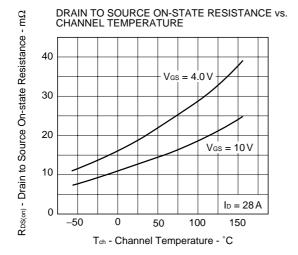
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

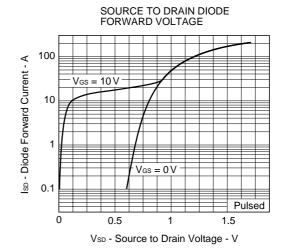


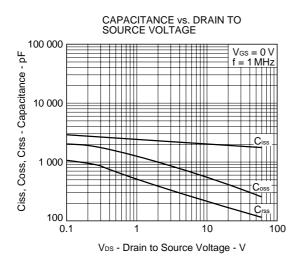
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

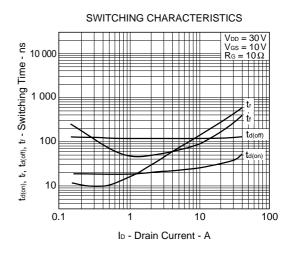


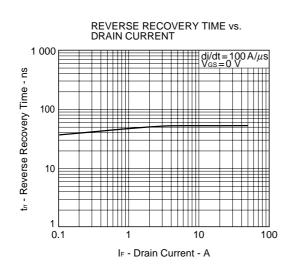


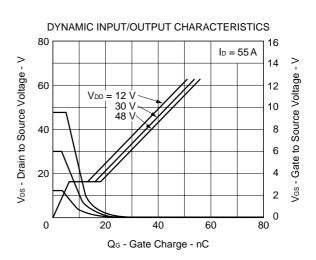


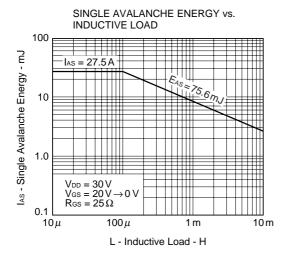


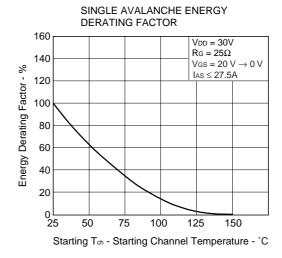










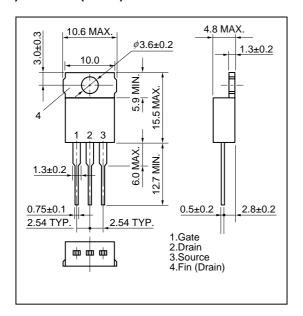


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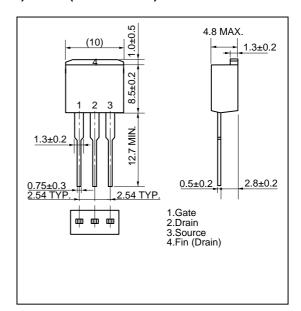


章ACKAGE ORAWINGS (Unit:mm)

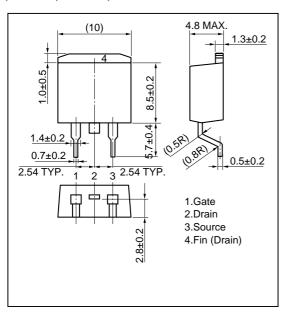
1)TO-220AB (MP-25)



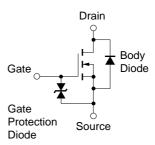
2)TO-262 (MP-25 Fin Cut)



3)TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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 - Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)
 - Specific: Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

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